

<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09265073	OVARD ET AL.
Examiner	Art Unit	
Nam V Nguyen	2612	

### SEARCHED

Class	Subclass	Date	Examiner
340	10.4;	2/9/09	NN
455	38.2; 106; 73	2/9/09	NN

### SEARCH NOTES

Search Notes	Date	Examiner
Search EAST; uspat; us-pub; epo; jpo and derwent (updated search).	2/9/09	NN
Search Terms: interrogation with plurality of stations; rf circuitry for different ranges.	2/9/09	NN

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/N. V. N./  
Examiner.Art Unit 2612